## Notice of References Cited Application/Control No. O9/901,323 Applicant(s)/Patent Under R examination KRUPKA, EYAL Examiner Kevin Y Kim Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

	_	5	D-4-	1	<u> </u>
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,475,710	12-1995	Ishizu et al.	375/232
	В	US-6,421,380	07-2002	Gu et al.	375/232
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	_	US-			
	J	US-			
	к	US-			
	٦	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
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	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

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